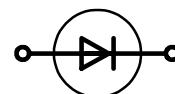


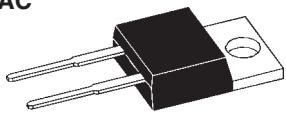
HiPerFRED™ Epitaxial Diode with soft recovery

I_{FAV} = 30 A
V_{RRM} = 300 V
t_{rr} = 30 ns

V _{RSM} V	V _{RRM} V	Type
300	300	DSEP 29-03A



TO-220 AC



A = Anode, C = Cathode, TAB = Cathode

Symbol	Conditions	Maximum Ratings		Features
I _{FRMS}		35	A	
I _{FAVM}	T _C = 145°C; rectangular, d = 0.5	30	A	
I _{FSM}	T _{VJ} = 45°C; t _p = 10 ms (50 Hz), sine	300	A	
E _{AS}	T _{VJ} = 25°C; non-repetitive I _{AS} = 3 A; L = 180 μH	1.2	mJ	
I _{AR}	V _A = 1.5·V _R typ.; f = 10 kHz; repetitive	0.3	A	
T _{VJ}		-55...+175	°C	
T _{VJM}		175	°C	
T _{stg}		-55...+150	°C	
P _{tot}	T _C = 25°C	165	W	
M _d	mounting torque	0.4...0.6	Nm	
Weight	typical	2	g	

Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

Symbol	Conditions	Characteristic Values		Features
		typ.	max.	
I _R ①	V _R = V _{RRM} ; T _{VJ} = 25°C T _{VJ} = 150°C	10 1	μA mA	
V _F ②	I _F = 30 A; T _{VJ} = 150°C T _{VJ} = 25°C	0.93 1.26	V V	
R _{thJC} R _{thCH}		0.5	0.9 K/W	
t _{rr}	I _F = 1 A; -di/dt = 200 A/μs; V _R = 30 V; T _{VJ} = 25°C	30	ns	
I _{RM}	V _R = 100 V; I _F = 50 A; -di _F /dt = 100 A/μs T _{VJ} = 100°C	7	A	

Pulse test: ① Pulse Width = 5 ms, Duty Cycle < 2.0%
 ② Pulse Width = 300 μs, Duty Cycle < 2.0%

Data according to IEC 60747 and per diode unless otherwise specified

Recommended replacement:
DPG30I300PA

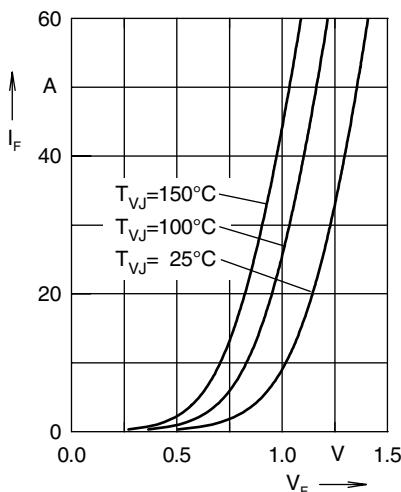
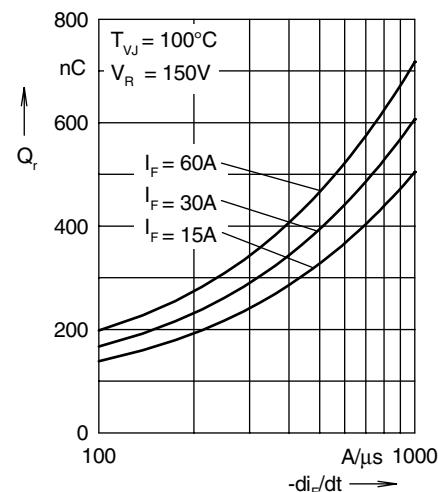
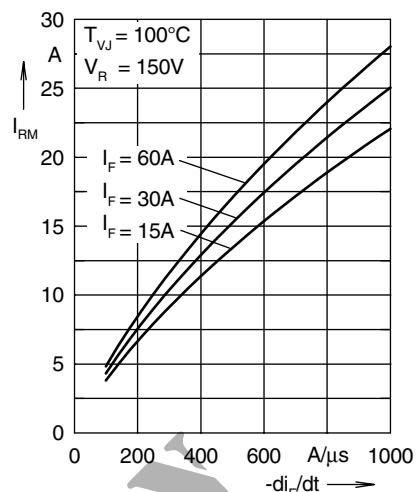
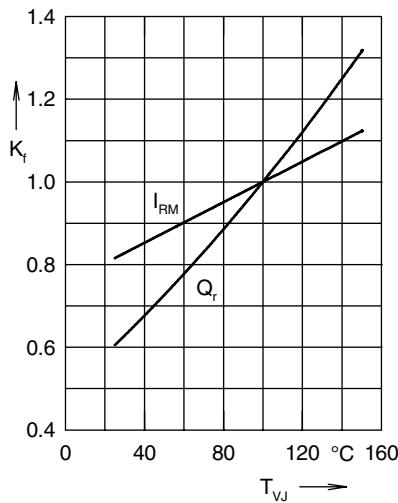
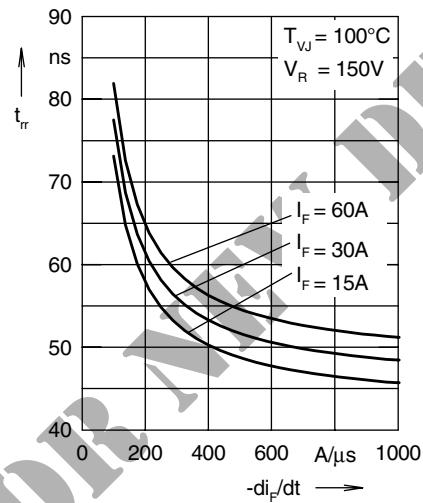
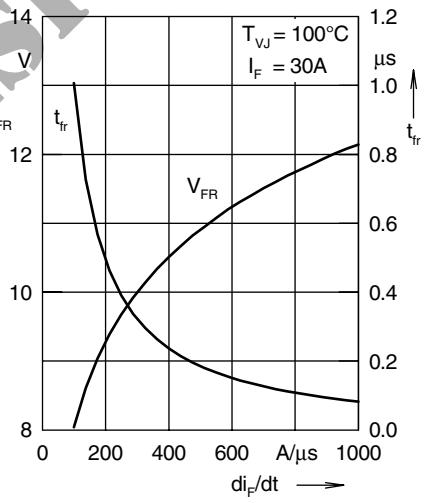
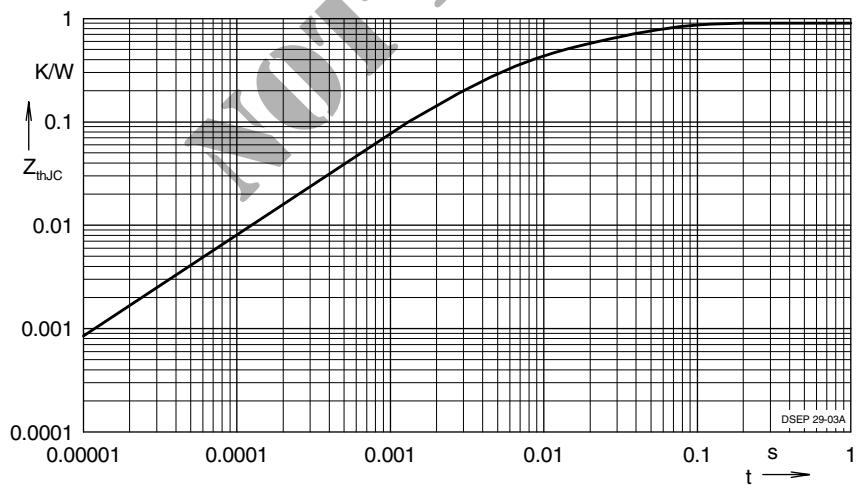
Fig. 1 Forward current I_F versus V_F Fig. 2 Reverse recovery charge Q_r versus $-di_F/dt$ Fig. 3 Peak reverse current I_{RM} versus $-di_F/dt$ Fig. 4 Dynamic parameters Q_r , I_{RM} versus T_{VJ} Fig. 5 Recovery time t_{rr} versus $-di_F/dt$ Fig. 6 Peak forward voltage V_{FR} and t_{tr} versus di_F/dt 

Fig. 7 Transient thermal resistance junction to case

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NOTE: Fig. 2 to Fig. 6 shows typical values